

# AOT2146L/AOB2146L

40V N-Channel AlphaSGT™

## **General Description**

- Trench Power AlphaSGT<sup>™</sup> technology
- Low R<sub>DS(ON)</sub>
- Low Gate Charge
- Optimized Ruggedness
- RoHS and Halogen-Free Compliant

### **Applications**

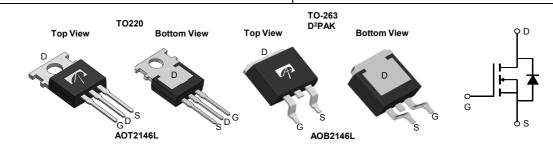
- DC Motor Driver
- Synchronous Rectification in DC/DC and AC/DC Converters

## **Product Summary**

 $\begin{array}{lll} V_{DS} & 40V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 105A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 2.8 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 3.9 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested





Orderable Part Number	Package Type	Form	Minimum Order Quantity		
AOT2146L	TO-220	Tube	1000		
AOB2146L	TO-263	Tape & Reel	800		

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	40	V	
Gate-Source Voltage		$V_{GS}$	±20	V	
Continuous Drain	T <sub>C</sub> =25°C		105		
Current <sup>G</sup>	T <sub>C</sub> =100°C	I <sub>D</sub>	100	A	
Pulsed Drain Current <sup>c</sup>		I <sub>DM</sub>	345		
Continuous Drain Current	T <sub>A</sub> =25°C		42		
	T <sub>A</sub> =70°C	IDSM	33.5	A	
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	38	Α	
Avalanche energy	L=0.3mH	E <sub>AS</sub>	217	mJ	
Power Dissipation <sup>B</sup>	T <sub>C</sub> =25°C	Р	119	10/	
	T <sub>C</sub> =100°C	— P <sub>D</sub>	47.5	─ W	
Power Dissipation <sup>A</sup>	T <sub>A</sub> =25°C	В	8.3	w	
	T <sub>A</sub> =70°C	P <sub>DSM</sub>	5.3		
Junction and Storage	e Temperature Range	T <sub>1</sub> , T <sub>STC</sub>	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	12	15	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	ГС⊕ЈД	50	60	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.85	1.05	°C/W	



# Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		40			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V				1	
			T <sub>J</sub> =55°C			5	μA
$I_{GSS}$	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS,}I_{D}=250\mu A$		1.5	1.95	2.5	V
	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_D$ =20A			2.3	2.8	mΩ
R <sub>DS(ON)</sub>			T <sub>J</sub> =125°C		3.5	4.3	
		$V_{GS}$ =4.5V, $I_D$ =20A			3.1	3.9	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A			100		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			0.68	1	V
Is	Maximum Body-Diode Continuous Cur	rent <sup>G</sup>			105	Α	
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance			3830		pF	
Coss	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=1MHz			630		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				45		pF
$R_g$	Gate resistance	f=1MHz		1	2	3	Ω
SWITCHI	NG PARAMETERS	•	•		•	•	•
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =20A			50	70	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge				20	30	nC
$Q_{gs}$	Gate Source Charge				13.5		nC
$Q_{gd}$	Gate Drain Charge				3		nC
Q <sub>oss</sub>	Output Charge	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V			27		nC
t <sub>D(on)</sub>	Turn-On DelayTime				12		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =20V, $R_L$ =1.0 $\Omega$ , $R_{GEN}$ =3 $\Omega$			12		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				44		ns
t <sub>f</sub>	Turn-Off Fall Time				9		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μs			18.5		ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	l <sub>F</sub> =20A, di/dt=500A/μs			50		nC

A. The value of R<sub>BJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation P<sub>DSM</sub> is based on R <sub>8JA</sub> t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

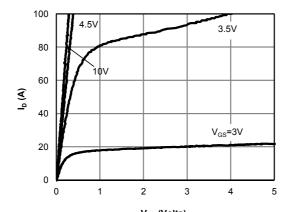
C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}\text{=}150^{\circ}\,$  C.

D. The  $R_{\text{NJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{NJC}}$  and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu$ s pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

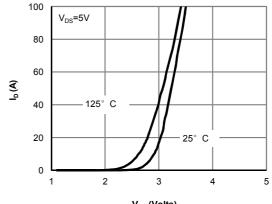
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



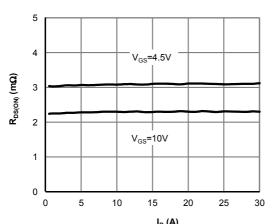
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



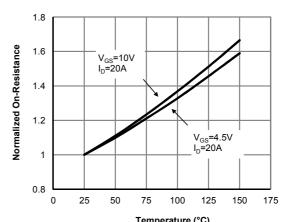
V<sub>DS</sub> (Volts) Figure 1: On-Region Characteristics (Note E)



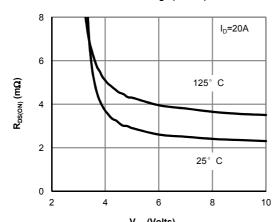
V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)



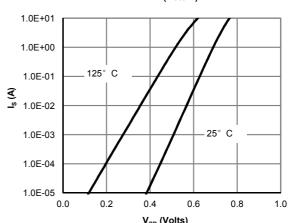
 $\label{eq:local_local} \textbf{I}_{\text{D}}\left(\textbf{A}\right)$  Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



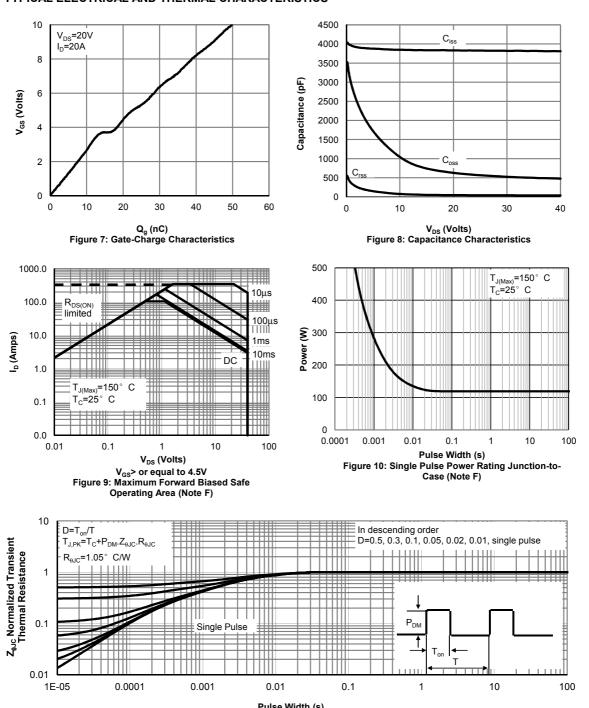
V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



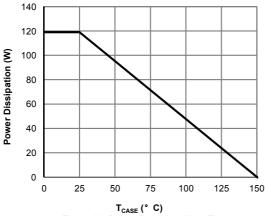
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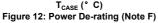


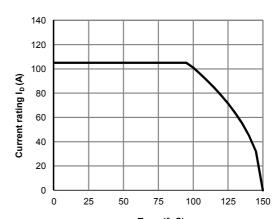
Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



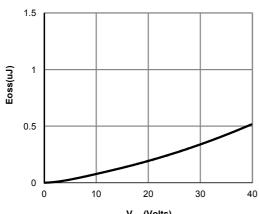
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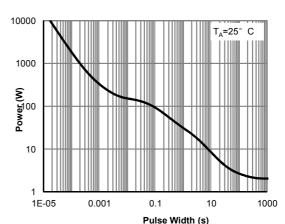




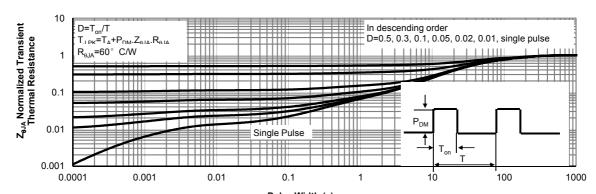
T<sub>CASE</sub> (° C)
Figure 13: Current De-rating (Note F)



V<sub>DS</sub> (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

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Figure A: Gate Charge Test Circuit & Waveforms

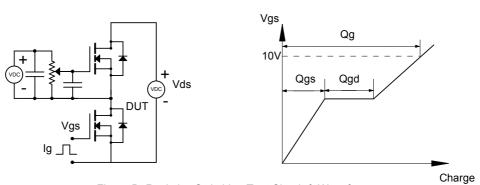


Figure B: Resistive Switching Test Circuit & Waveforms

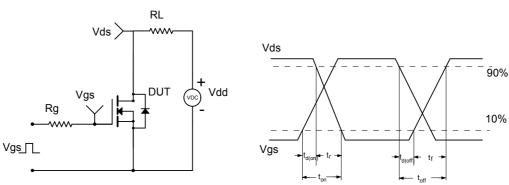


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

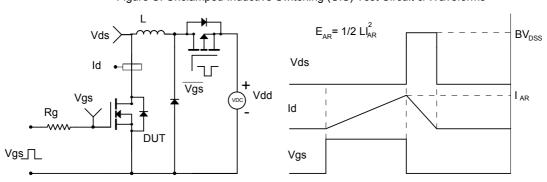
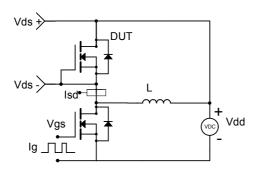
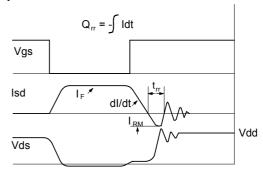


Figure D: Diode Recovery Test Circuit & Waveforms





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